

Complementary Silicon Plastic Power Transistors

 \ldots designed for use in general–purpose amplifier and switching applications.

• DC Current Gain Specified to 7.0 Amperes

• Collector-Emitter Sustaining Voltage —

• High Current Gain — Bandwidth Product

$$f_T = 4.0 \text{ MHz (Min)} @ I_C = 500 \text{ mAdc} - 2N6288, 90, 92$$

= 10 MHz (Min) @ $I_C = 500 \text{ mAdc} - 2N6107, 09, 11$

- TO-220AB Compact Package
- These devices are available in Pb-free package(s). Specifications herein apply to both standard and Pb-free devices. Please see our website at www.onsemi.com for specific Pb-free orderable part numbers, or contact your local ON Semiconductor sales office or representative.

*MAXIMUM RATINGS

Rating	Symbol	2N6111 2N6288	2N6109	2N6107 2N6292	Unit
Collector-Emitter Voltage	V _{CEO}	30	50	70	Vdc
Collector-Base Voltage	V_{CB}	40	60	80	Vdc
Emitter-Base Voltage	V _{EB}	5.0		Vdc	
Collector Current — Continuous Peak	I _C	7.0 10		Adc	
Base Current	I _B		3.0		Adc
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	40 0.32		Watts W/°C	
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-	-65 to +15	0	°C

THERMAL CHARACTERISTICS

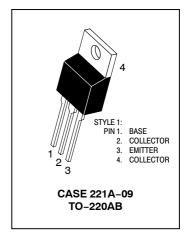
Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	3.125	°C/W
*Indicates JEDEC Registered Data.			

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

2N6107 2N6109* 2N6111 2N6288 2N6292*

*ON Semiconductor Preferred Device

7 AMPERE
POWER TRANSISTORS
COMPLEMENTARY
SILICON
30-50-70 VOLTS
40 WATTS



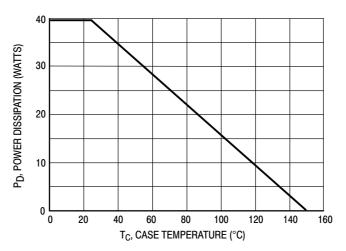
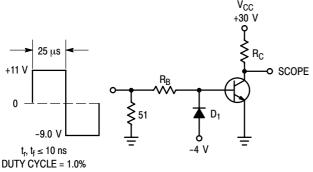


Figure 1. Power Derating

***ELECTRICAL CHARACTERISTICS** ($T_C = 25^{\circ}C$ unless otherwise noted)

Characteristic		Symbol	Min	Max	Unit
OFF CHARACTERISTICS		•		•	•
Collector–Emitter Sustaining Voltage (1) $(I_C = 100 \text{ mAdc}, I_B = 0)$	2N6111, 2N6288 2N6109 2N6107, 2N6292	V _{CEO(sus)}	30 50 70	_ _ _	Vdc
Collector Cutoff Current $(V_{CE} = 20 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 40 \text{ Vdc}, I_B = 0)$ $(V_{CE} = 60 \text{ Vdc}, I_B = 0)$	2N6111, 2N6288 2N6109 2N6107, 2N6292	I _{CEO}	_ _ _	1.0 1.0 1.0	mAdc
	2N6111, 2N6288 2N6109 2N6107, 2N6292 2N6111, 2N6288 2N6109 2N6107, 2N6292	I _{CEX}	_ _ _ _ _	100 100 100 2.0 2.0 2.0	μAdc mAdc
Emitter Cutoff Current (V _{BE} = 5.0 Vdc, I _C = 0)		I _{EBO}	_	1.0	mAdc
ON CHARACTERISTICS (1)					
DC Current Gain $ \begin{aligned} &(I_C = 2.0 \text{ Adc, } V_{CE} = 4.0 \text{ Vdc}) \\ &(I_C = 2.5 \text{ Adc, } V_{CE} = 4.0 \text{ Vdc}) \\ &(I_C = 3.0 \text{ Adc, } V_{CE} = 4.0 \text{ Vdc}) \\ &(I_C = 7.0 \text{ Adc, } V_{CE} = 4.0 \text{ Vdc}) \end{aligned} $	2N6107, 2N6292 2N6109 2N6111, 2N6288 All Devices	h _{FE}	30 30 30 2.3	150 150 150	_
Collector–Emitter Saturation Voltage (I _C = 7.0 Adc, I _B = 3.0 Adc)		V _{CE(sat)}	_	3.5	Vdc
Base–Emitter On Voltage (I _C = 7.0 Adc, V _{CE} = 4.0 Vdc)		V _{BE(on)}	_	3.0	Vdc
DYNAMIC CHARACTERISTICS		-1		•	
Current Gain — Bandwidth Product (2) ($I_C = 500 \text{ mAdc}$, $V_{CE} = 4.0 \text{ Vdc}$, $f_{test} = 1.0 \text{ MHz}$)	2N6288, 92 2N6107, 09, 11	f _T	4.0 10	_ _	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 1.0 MHz)		C _{ob}		250	pF
Small-Signal Current Gain (I _C = 0.5 Adc, V _{CE} = 4.0 Vdc, f = 5	50 kHz)	h _{fe}	20	_	_

^{*}Indicates JEDEC Registered Data.
(1) Pulse Test: Pulse Width $\leq 300 \, \mu s$, Duty Cycle $\leq 2.0\%$.
(2) $f_T = |h_{fe}| \cdot f_{test}$.



 ${\rm R}_{\rm B}$ and ${\rm R}_{\rm C}$ are varied to obtain desired current levels

D1 MUST BE FAST RECOVERY TYPE, eg: 1N5825 USED ABOVE I_B \approx 100 mA MSD6100 USED BELOW I_B \approx 100 mA

Figure 2. Switching Time Test Circuit

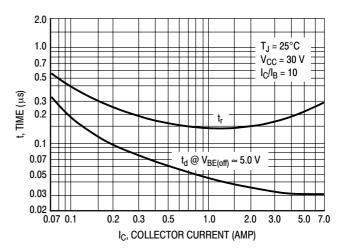


Figure 3. Turn-On Time

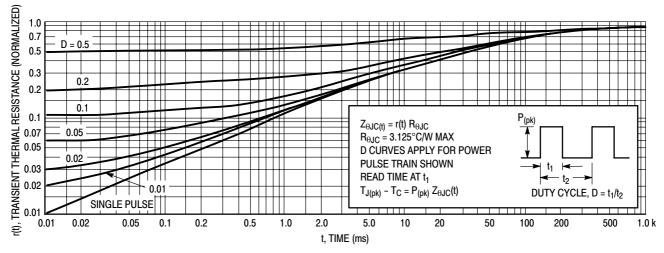


Figure 4. Thermal Response

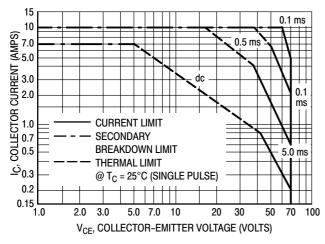


Figure 5. Active-Region Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 5 is based on $T_{J(pk)} = 150^{\circ} C$; T_C is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)} \le 150^{\circ} C$. $T_{J(pk)}$ may be calculated from the data in Figure 4. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

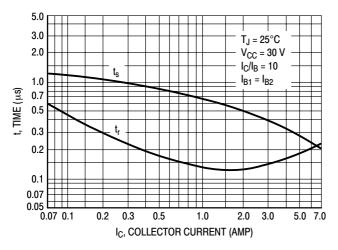


Figure 6. Turn-Off Time

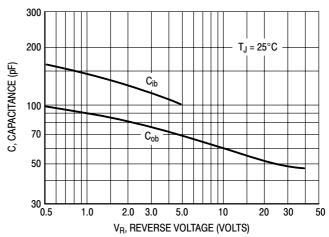
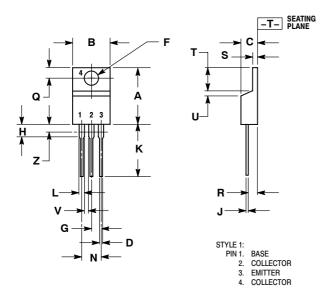


Figure 7. Capacitance

PACKAGE DIMENSIONS

TO-220AB **CASE 221A-09 ISSUE AA**



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
С	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
J	0.018	0.025	0.46	0.64	
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
T	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

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